Search Notes						
			i i i i i			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/891,925	YANO ET AL.	
Examiner	Art Unit	

2811

Sara W. Crane

	SEAR	CHED	
Class	Subclass	Date	Examiner
updat	e origin	al	
Seuro	hi o		
257	139	3/07	Sw
	212		
	341		
	401		
	630	•	
	646		
	649		
	I		1

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		-			

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
,		
·		
1		